

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/612,914	HANNA ET AL	
Examiner	Art Unit	
Christopher H. Yaen	1643	

	SEARCHED					
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
Updated searches	8/17/2007	СНҮ
reviewed 10/211357	8/17/2007	СНҮ
palm inventor search	8/17/2007	СНҮ
Stic SEQ. ID No: 1,5,7,9,11 (see 10/211357)	8/17/2007	СНҮ
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